October 2014

FDMS7570S

N-Channel PowerTrench® SyncFET™
25 V, 49 A, 1.95 mΩ

Features

- Max $r_{DS(on)}$ = 1.95 mΩ at V_{GS} = 10 V, I_D = 28 A

- Max $r_{DS(on)}$ = 2.85 mΩ at V_{GS} = 4.5 V, I_D = 22 A

- Advanced Package and Silicon combination for low $r_{DS(on)}$ and high efficiency

- SyncFET Schottky Body Diode

- MSL1 robust package design

- 100% UIL tested

- RoHS Compliant

General Description

The FDMS7570S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for Synchronous Buck Converters

- Notebook

- Server

- Telecom

- High Efficiency DC-DC Switch Mode Power Supplies

Top

Bottom

Pin 1

S S S G

D D D D

Power 56

D	5		4	G
D	6		3	S
D	7		2	S
D	8		1	S
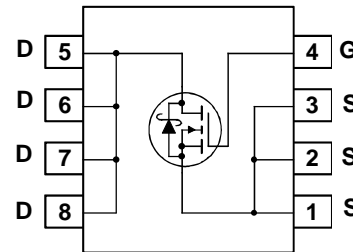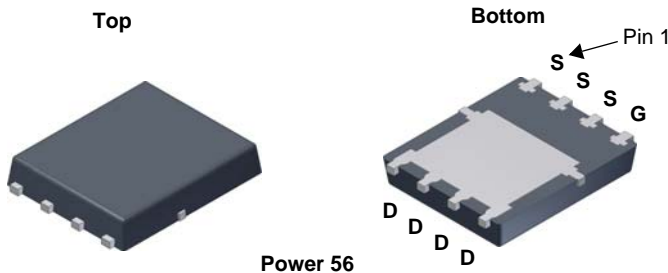
MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			25	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
I_D	Drain Current -Continuous (Package limited)	T_C = 25 °C		49	A
	-Continuous (Silicon limited)	T_C = 25 °C		156	
	-Continuous	T_A = 25 °C	(Note 1a)	28	
	-Pulsed			180	
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	144	mJ
P_D	Power Dissipation	T_C = 25 °C		83	W
	Power Dissipation	T_A = 25 °C	(Note 1a)	2.5	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7570S	FDMS7570S	Power 56	13 ''	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 1 mA, V_{GS} = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25 °C		22		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 20 V, V_{GS} = 0 V			500	μA
I_{GSS}	Gate to Source Leakage Current, Forward	V_{GS} = 20 V, V_{DS} = 0 V			100	nA
On Characteristics (Note 2)						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 1 mA	1.2	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25 °C		-5		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 28 A		1.6	1.95	mΩ
		V_{GS} = 4.5 V, I_D = 22 A		2.3	2.85	
		V_{GS} = 10 V, I_D = 28 A, T_J = 125 °C		2.4	3.0	
g_{FS}	Forward Transconductance	V_{DS} = 5 V, I_D = 28 A		170		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 13 V, V_{GS} = 0 V, f = 1 MHz		3392	4515	pF
C_{oss}	Output Capacitance			912	1215	pF
C_{rss}	Reverse Transfer Capacitance			172	260	pF
R_g	Gate Resistance			1.2	2.1	Ω
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 13 V, I_D = 28 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		14	25	ns
t_r	Rise Time			5.9	12	ns
$t_{d(off)}$	Turn-Off Delay Time			34	55	ns
t_f	Fall Time			4	10	ns
Q_g	Total Gate Charge	V_{GS} = 0 V to 10 V		49	69	nC
Q_g	Total Gate Charge	V_{GS} = 0 V to 4.5 V V_{DD} = 13 V, I_D = 28 A		22	32	nC
Q_{gs}	Gate to Source Gate Charge			9.9		nC
Q_{gd}	Gate to Drain "Miller" Charge			5.3		nC
Drain-Source Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 2 A (Note 2)		0.43	0.8	V
		V_{GS} = 0 V, I_S = 28 A (Note 2)		0.78	1.2	
t_{rr}	Reverse Recovery Time	I_F = 28 A, di/dt = 300 A/ μs		28	45	ns
Q_{rr}	Reverse Recovery Charge			27	43	nC

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.
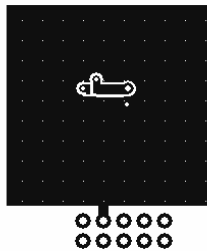
a. 50 °C/W when mounted on a 1 in^2 pad of 2 oz copper.
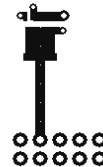
b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

3. E_{AS} of 144 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 17 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 25 A.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

Typical Characteristics $T_J = 25\ °C$ unless otherwise noted

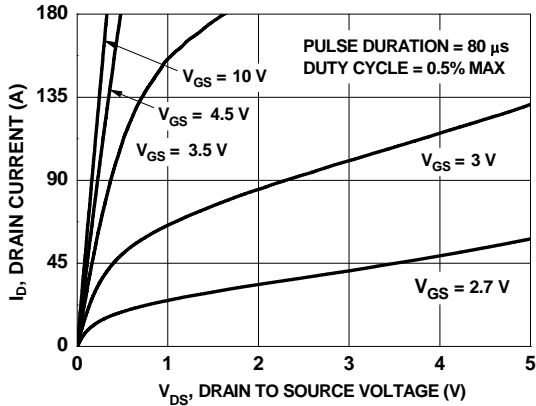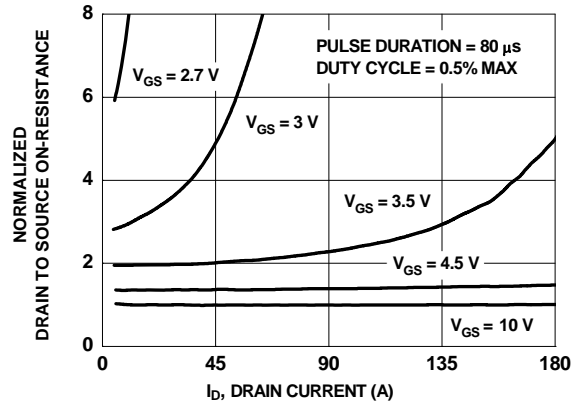**Figure 1. On Region Characteristics**

PULSE DURATION = 80 µs
DUTY CYCLE = 0.5% MAX

V_{GS} = 10 V
V_{GS} = 4.5 V
V_{GS} = 3.5 V
V_{GS} = 3 V
V_{GS} = 2.7 V

I_D, DRAIN CURRENT (A)
V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

PULSE DURATION = 80 µs
DUTY CYCLE = 0.5% MAX

V_{GS} = 2.7 V
V_{GS} = 3 V
V_{GS} = 3.5 V
V_{GS} = 4.5 V
V_{GS} = 10 V

NORMALIZED DRAIN TO SOURCE ON-RESISTANCE
I_D, DRAIN CURRENT (A)
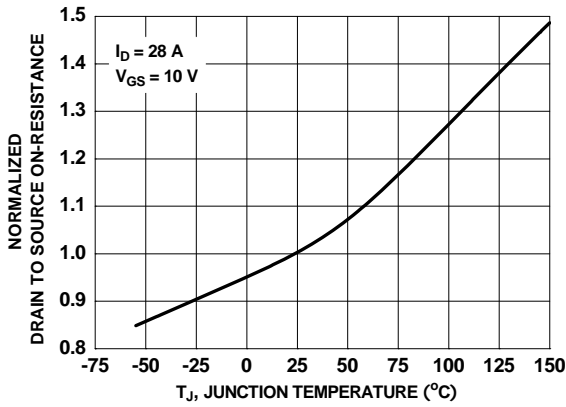
Figure 3. Normalized On Resistance vs Junction Temperature

I_D = 28 A
V_{GS} = 10 V

NORMALIZED DRAIN TO SOURCE ON-RESISTANCE
T_J, JUNCTION TEMPERATURE (^{o}C)
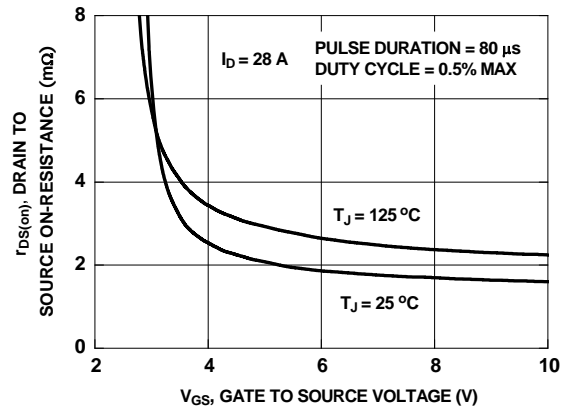
Figure 4. On-Resistance vs Gate to Source Voltage

I_D = 28 A
PULSE DURATION = 80 µs
DUTY CYCLE = 0.5% MAX

T_J = 125 ^{o}C
T_J = 25 ^{o}C

$r_{DS(on)}$, DRAIN TO SOURCE ON-RESISTANCE (mΩ)
V_{GS}, GATE TO SOURCE VOLTAGE (V)
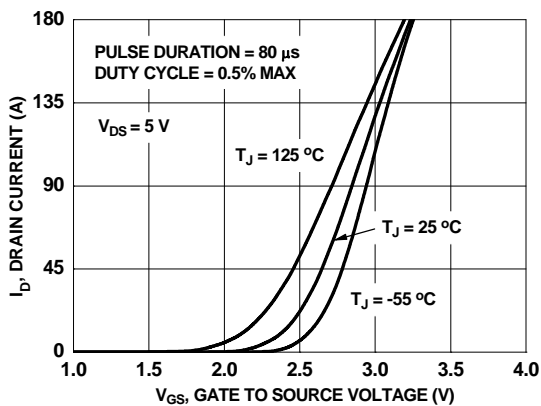
Figure 5. Transfer Characteristics

PULSE DURATION = 80 µs
DUTY CYCLE = 0.5% MAX

V_{DS} = 5 V

T_J = 125 ^{o}C
T_J = 25 ^{o}C
T_J = -55 ^{o}C

I_D, DRAIN CURRENT (A)
V_{GS}, GATE TO SOURCE VOLTAGE (V)
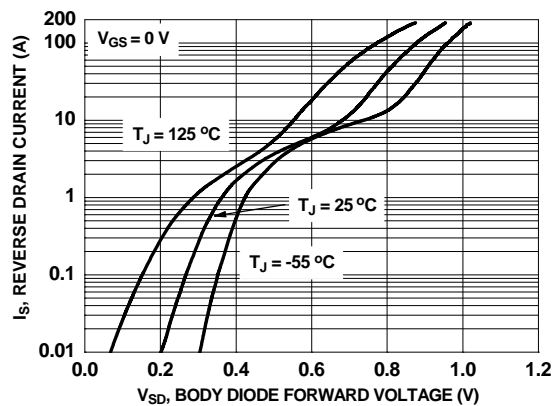
Figure 6. Source to Drain Diode Forward Voltage vs Source Current

V_{GS} = 0 V

T_J = 125 ^{o}C
T_J = 25 ^{o}C
T_J = -55 ^{o}C

I_S, REVERSE DRAIN CURRENT (A)
V_{SD}, BODY DIODE FORWARD VOLTAGE (V)

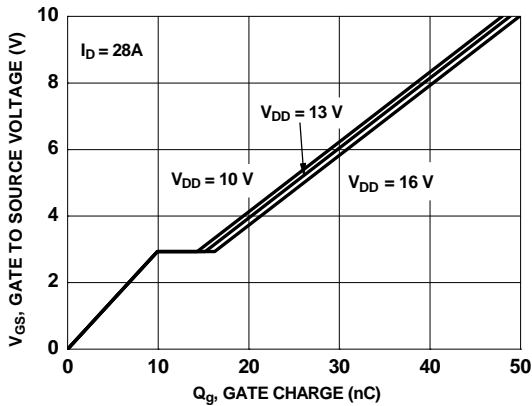## Typical Characteristics T_J = 25 °C unless otherwise noted

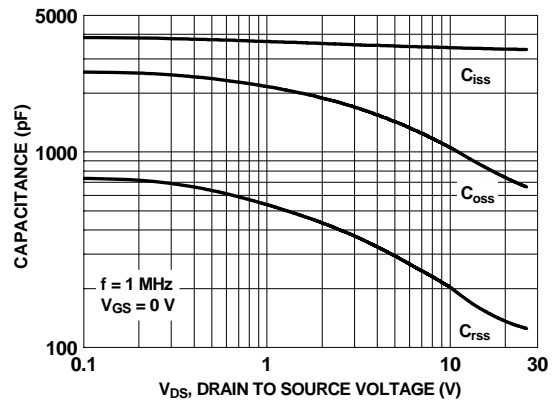**Figure 7. Gate Charge Characteristics**

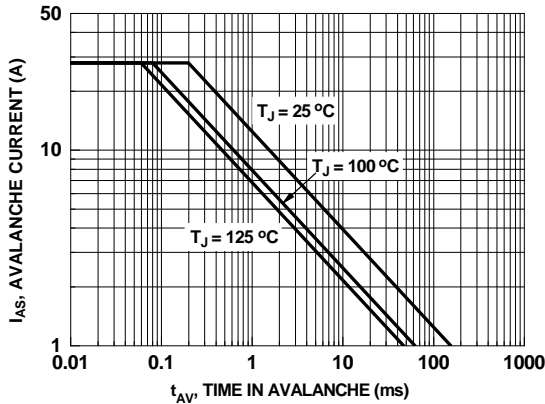**Figure 8. Capacitance vs Drain to Source Voltage**

Figure 9. Unclamped Inductive Switching Capability
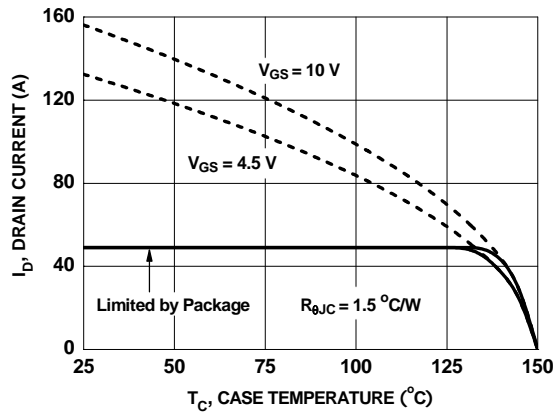

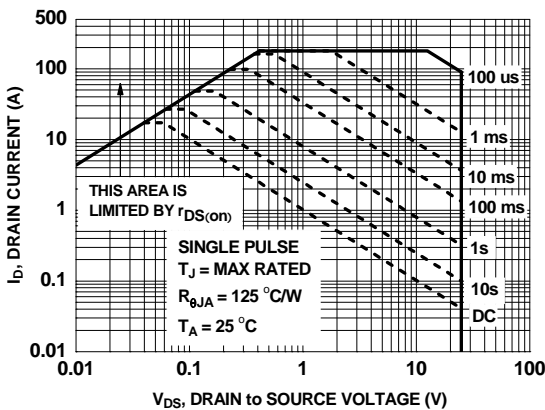**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

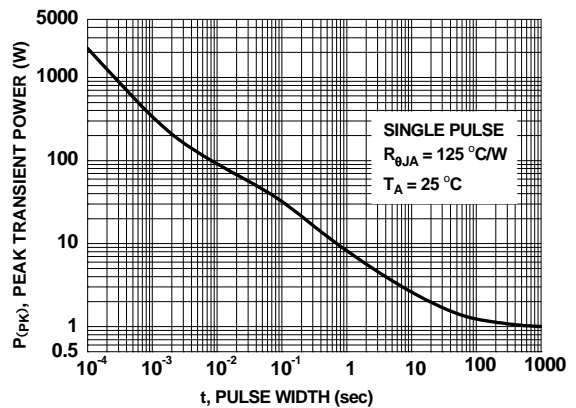**Figure 11. Forward Bias Safe Operating Area**

Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

NORMALIZED THERMAL IMPEDANCE, $Z_{\theta JA}$

DUTY CYCLE-DESCENDING ORDER

D = 0.5
0.2
0.1
0.05
0.02
0.01

SINGLE PULSE

$R_{\theta JA}$ = 125 °C/W

P_{DM}

t_1

t_2

NOTES:
DUTY FACTOR: D = t_1/t_2
PEAK T_J = P_{DM} x $Z_{\theta JA}$ x $R_{\theta JA}$ + T_A

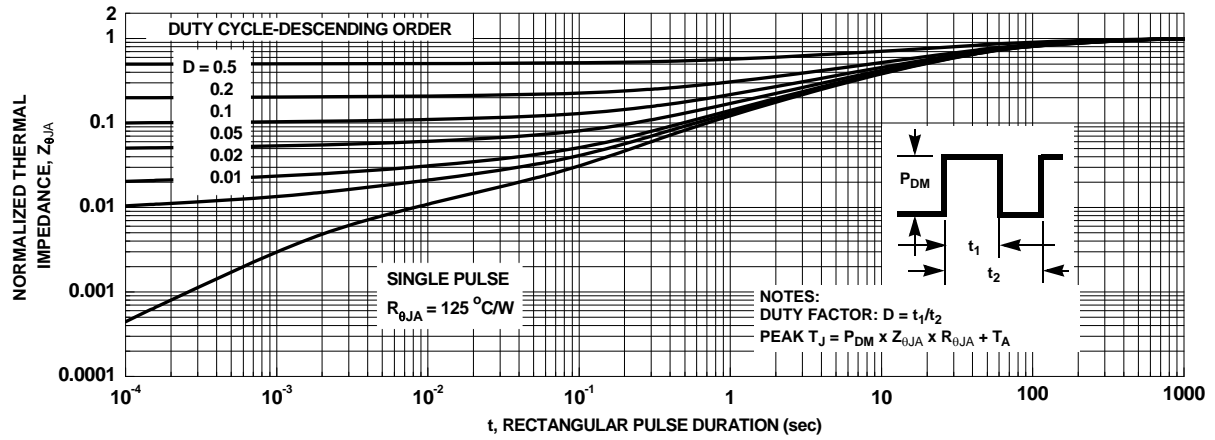t, RECTANGULAR PULSE DURATION (sec)

Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS7570S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.
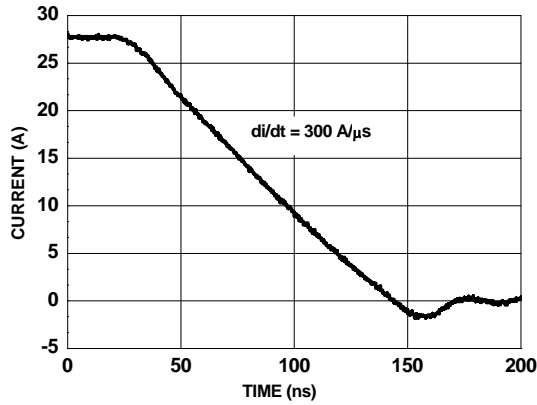
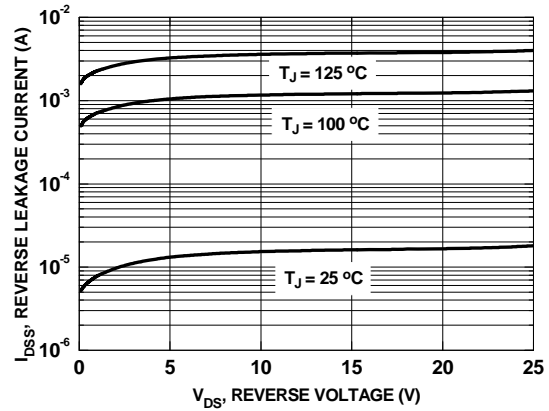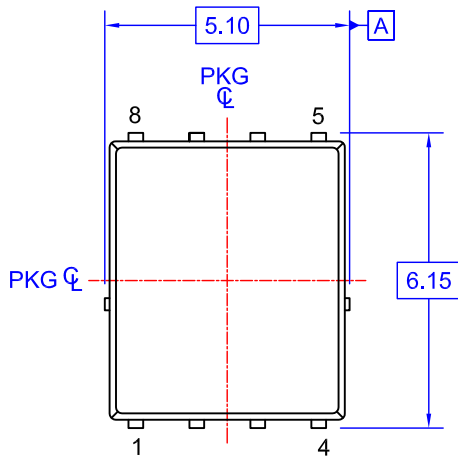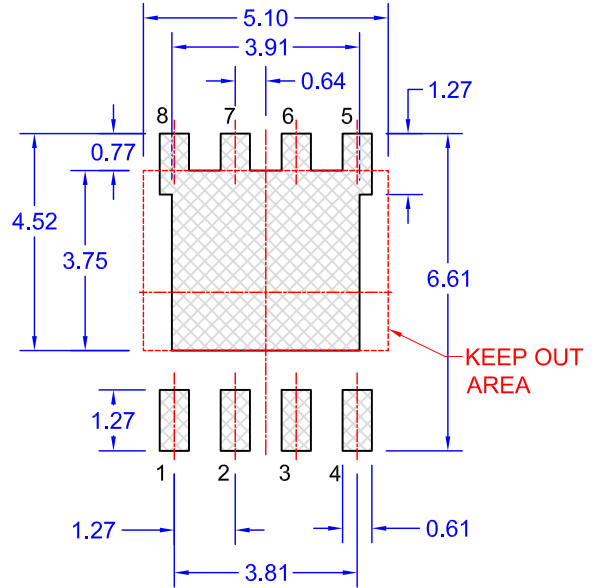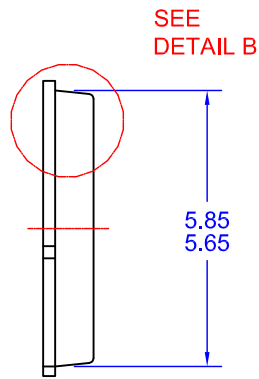**Figure 14. FDMS7570S SyncFET body diode reverse recovery characteristic**

Figure 15. SyncFET body diode reverses leakage versus drain-source voltage

TOP VIEW

5.10 | A

PKG CL

8 5

PKG CL

1 4

6.15

SEE DETAIL B

5.85
5.65

LAND PATTERN RECOMMENDATION

5.10
3.91
0.64
1.27

8 7 6 5

0.77

4.52

3.75

6.61

KEEP OUT AREA

1.27

1 2 3 4

1.27

0.61

3.81

SIDE VIEW

5.00
4.80

SEE DETAIL C

BOTTOM VIEW

5.20
4.80

3.81

1.27

(0.34)

0.51
0.31 (8X)

⊕ 0.10 Ⓜ C A B

1 2 3 4

0.76
0.51

(0.52)

(0.50)

(0.30)
(2X)

6.25
5.90

3.48 +0.30 −0.10

8 7 6 5

0.20 +0.10 −0.15 (8X)

3.96
3.61

0.44±0.10
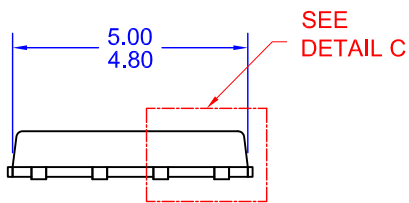
OPTIONAL DRAFT ANGLE MAY APPEAR ON FOUR SIDES OF THE PACKAGE

0°-12°

// 0.10 C

8X

⌓ 0.08 C

0.05
0.00

0.35
0.15

1.10
0.90

C

SEATING PLANE

DETAIL C
SCALE: 2:1

0.35
0.15

0.30
0.05

0°-12°
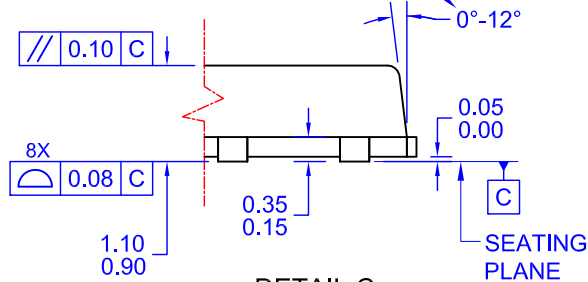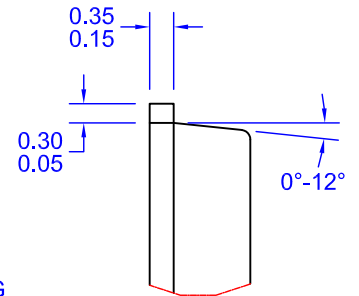
DETAIL B
SCALE: 2:1
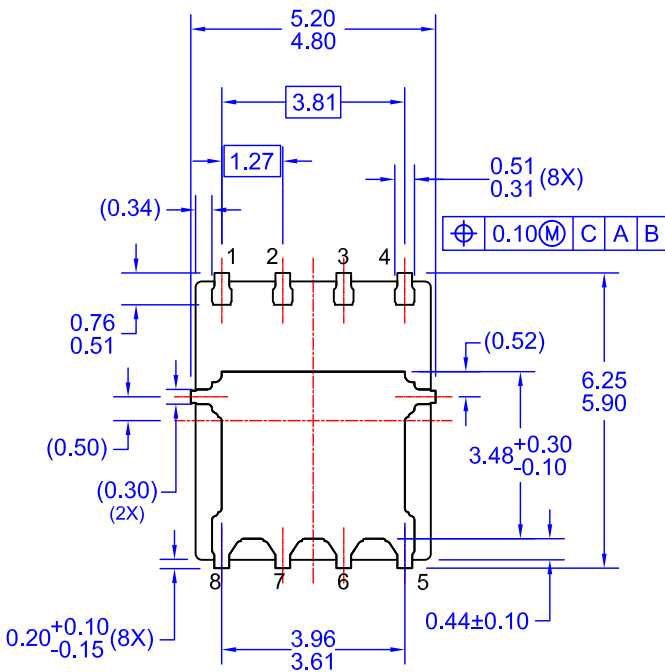
NOTES: UNLESS OTHERWISE SPECIFIED
  A. PACKAGE STANDARD REFERENCE: JEDEC MO-240,
     ISSUE A, VAR. AA, DATED OCTOBER 2002.
  B. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH.
     MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
  C. ALL DIMENSIONS ARE IN MILLIMETERS.
  D. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
  E. IT IS RECOMMENDED TO HAVE NO TRACES OR
     VIAS WITHIN THE KEEP OUT AREA.
  F. DRAWING FILE NAME: PQFN08AREV10

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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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